


<b>Search Notes</b>  	<b>Application/Control No.</b>  10506835	<b>Applicant(s)/Patent Under Reexamination</b>  WEI, YUMIN
	<b>Examiner</b>  Andramuno, Franklin S	<b>Art Unit</b>  2623

SEARCHED			
Class	Subclass	Date	Examiner
725	46	11/18/2008	FA
348	732	11/18/2008	FA
	text search	11/18/2008	FA

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Chris Kelley	10/18/2007	FA

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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